

Notice of References Cited	Application/Control No. 10/593,591		Applicant(s)/Patent Under Reexamination ZENPO ET AL.	
	Examiner SEYED M. MALEKZADEH		Art Unit 1791	Page 1 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,104,529 A	01-1938	SAMUEL RODNICK	425/449
*	B	US-2,218,767 A	10-1940	PFEIFER FREDERICK W	425/432
*	C	US-2,637,888 A	05-1953	LOUIS BUSHORE ALBERT	425/219
*	D	US-2,987,484 A	06-1961	LUNDBERG OLLE I; et. al.	510/145
*	E	US-3,328,852 A	07-1967	ELLS ROBERT W	164/201
*	F	US-3,599,282 A	08-1971	Meyers et al.	425/4R
*	G	US-7,264,463	09-2007	Domodossola et al.	425/444
*	H	US-3,624,825 A	11-1971	Heitzman, Charles J.	425/330
*	I	US-3,659,986 A	05-1972	Gelbman, Nathan L.	425/88
*	J	US-3,712,781 A	01-1973	Schmier, Jacob	425/161
*	K	US-3,804,568 A	04-1974	Rees, Herbert	425/139
*	L	US-3,813,201 A	05-1974	Frederick et al.	425/562
*	M	US-3,871,801 A	03-1975	Buchmann, Rudolf C.	425/4R

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/593,591		Applicant(s)/Patent Under Reexamination ZENPO ET AL.	
	Examiner SEYED M. MALEKZADEH		Art Unit 1791	Page 2 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,929,173 A	12-1975	Mauroner, Curtis	141/74
*	B	US-3,992,501 A	11-1976	Tatzel et al.	264/126
*	C	US-4,028,450 A	06-1977	Gould, Walter M.	264/45.5
*	D	US-4,036,923 A	07-1977	Saidla, Glen E. W.	264/45.3
*	E	US-4,118,165 A	10-1978	Christian, Alfred	425/262
*	F	US-4,227,556 A	10-1980	Hurst et al.	141/137
*	G	US-4,295,810 A	10-1981	Dennert et al.	425/110
*	H	US-4,448,736 A	05-1984	Emery et al.	264/40.1
*	I	US-4,557,881 A	12-1985	Rabotski, John	264/40.4
*	J	US-4,735,564 A	04-1988	Sasaki et al.	425/145
*	K	US-4,780,256 A	10-1988	Sasaki et al.	264/40.1
*	L	US-4,923,666 A	05-1990	Yamazaki et al.	264/572
*	M	US-4,963,083 A	10-1990	Stalter et al.	425/125

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/593,591		Applicant(s)/Patent Under Reexamination ZENPO ET AL.	
	Examiner SEYED M. MALEKZADEH		Art Unit 1791	Page 3 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,354,194 A	10-1994	Kresak, Paul F.	425/436R
*	B	US-5,449,698 A	09-1995	Mabuchi et al.	521/51
*	C	US-6,036,993 A	03-2000	Frazzitta, Joseph	427/8
*	D	US-6,227,835 B1	05-2001	Bazzica, Carlo	425/3
*	E	US-6,231,326 B1	05-2001	Sisbarro, Frederick P.	425/74
*	F	US-6,352,659 B1	03-2002	Clark et al.	264/51
*	G	US-2002/0127295 A1	09-2002	PADOVANI, PIETRO	425/388
*	H	US-2003/0107155 A1	06-2003	Olaru et al.	264/328.1
*	I	US-2003/0124033 A1	07-2003	Baker et al.	422/128
*	J	US-6,612,190 B2	09-2003	Takeuchi et al.	73/865
*	K	US-2003/0209094 A1	11-2003	Takeuchi et al.	73/865
*	L	US-6,840,123 B2	01-2005	Takeuchi et al.	73/865
*	M	US-6,878,643 B2	04-2005	Krulevitch et al.	438/780

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/593,591		Applicant(s)/Patent Under Reexamination ZENPO ET AL.	
	Examiner SEYED M. MALEKZADEH		Art Unit 1791	Page 4 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,104,780 B2	09-2006	Domodossola et al.	425/534
*	B	US-7,128,564 B2	10-2006	Di Simone, John	425/556
*	C	US-7,264,463 B2	09-2007	Domodossola et al.	425/444
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.